

Search Notes

Application/Control No.

10/710,855

Examiner

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Applicant(s)/Patent under
Reexamination

CHANG, SUNG-SAN

Art Unit

2627

SEARCHED

Class	Subclass	Date	Examiner
369	30.27	10/23/2007	HH
369	53.25	10/23/2007	HH
720	600	10/23/2007	HH
720	601	10/23/2007	HH
720	602	10/23/2007	HH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Searched EAST and google patents. Consulted Primary Tan Dinh and Krista Bui.	10/23/2007	HH